

<b>Notice of References Cited</b>	Application/Control No. 10/618,136	Applicant(s)/Patent Under Reexamination LAPUH ET AL.	
	Examiner Xavier Szewai Wong	Art Unit 2616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,061,858 B1	06-2006	Di Benedetto et al.	370/219
*	B	US-7,197,660 B1	03-2007	Liu et al.	714/4
*	C	US-2002/0124107 A1	09-2002	Goodwin, Michele	709/242
*	D	US-2006/0062141 A1	03-2006	Oran, David R.	370/216
*	E	US-6,202,170 B1	03-2001	Busschbach et al.	714/11
*	F	US-2003/0048746 A1	03-2003	Guess et al.	370/219
*	G	US-2003/0016624 A1	01-2003	Bare, Ballard C.	370/217
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.